

**Search Notes**

Application/Control No.

10/721,075

Examiner

M. Alexandra Elve

Applicant(s)/Patent under  
Reexamination

TANAKA, KOICHIRO

Art Unit

3742

**SEARCHED**

Class	Subclass	Date	Examiner
update			
219	121.76	11/21/2010	MAE
219	121.78	11/21/2010	MAE
219	121.81	11/21/2010	MAE
219	121.85	11/21/2010	MAE
219	121.65	11/21/2010	MAE
219	121.66	11/21/2010	MAE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
<b>219</b>	<b>121.76</b>	<b>11/21/2010</b>	<b>MAE</b>
219	121.78	11/21/2010	MAE
219	121.81	11/21/2010	MAE

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
update US OCR, US PAT, US PG, Derwent, JPO, EPO	11/21/2010	MAE
Interference search	11/21/2010	MAE